## FEATURES

## Bidirectional level translation <br> Operates from 1.15 V to 5.5 V <br> Low quiescent current < $5 \mu \mathrm{~A}$ <br> No direction pin

## APPLICATIONS

SPI ${ }^{\oplus}$, MICROWIRE ${ }^{\text {TM }}$ level translation
Low voltage ASIC level translation
Smart card readers
Cell phones and cell phone cradles
Portable communications devices
Telecommunications equipment
Network switches and routers
Storage systems (SAN/NAS)
Computing/server applications
GPS

## Portable POS systems

Low cost serial interfaces

## GENERAL DESCRIPTION

The ADG3304 is a bidirectional logic level translator that contains four bidirectional channels. It can be used in multivoltage digital system applications such as data transfer between a low voltage DSP/controller and a higher voltage device using SPI and MICROWIRE interfaces. The internal architecture allows the device to perform bidirectional logic level translation without an additional signal to set the direction in which the translation takes place.

The voltage applied to $V_{C C A}$ sets the logic levels on the A side of the device, while $V_{C C Y}$ sets the levels on the $Y$ side. For proper operation, VCCA must always be less than $V_{c c y}$. The V CCA-compatible logic signals applied to the A side of the device appear as $\mathrm{V}_{\mathrm{CCY}}$-compatible levels on the Y side. Similarly, $\mathrm{V}_{\mathrm{CCY}}$-compatible logic levels applied to the $Y$ side of the device appear as $V_{C L C A^{-}}$ compatible logic levels on the A side.

FUNCTIONAL BLOCK DIAGRAM


Figure 1.

The enable pin (EN) provides three-state operation on both the A-side and the Y-side pins. When the EN pin is pulled low, the terminals on both sides of the device are in the high impedance state. The EN pin is referred to the V $\mathrm{V}_{\text {CCA }}$ supply voltage and driven high for normal operation.

The ADG3304 is available in compact 14-lead TSSOP, 12 -bump WLCSP, and 20-lead LFCSP packages. It is guaranteed to operate over the 1.15 V to 5.5 V supply voltage range and the extended $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ temperature range.

## PRODUCT HIGHLIGHTS

1. Bidirectional level translation.
2. Fully guaranteed over the 1.15 V to 5.5 V supply range.
3. No direction pin.
4. Available in 14-lead TSSOP, 12-bump WLCSP, and 20-lead LFCSP packages.

Rev. A
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## ADG3304

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## REVISION HISTORY

## 6/05-Rev. 0 to Rev. A

Added LFCSP Package ....................................................Universal

## 1/05-Revision 0: Initial Version

## SPECIFICATIONS ${ }^{1}$

$\mathrm{V}_{\mathrm{CCY}}=1.65 \mathrm{~V}$ to $5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{CCA}}=1.15 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{CCY}}, \mathrm{GND}=0 \mathrm{~V}$. All specifications $\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$, unless otherwise noted.
Table 1.

| Parameter | Symbol | Conditions | Min | Typ ${ }^{2}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| LOGIC INPUTS/OUTPUTS |  |  |  |  |  |  |
| A Side |  |  |  |  |  |  |
| Input High Voltage ${ }^{3}$ | $\mathrm{V}_{\text {HA }}$ | $V_{\text {CCA }}=1.15 \mathrm{~V}$ | $\mathrm{V}_{\text {CCA }}-0.3$ |  |  | V |
|  | $\mathrm{V}_{\text {HA }}$ | $\mathrm{V}_{\text {CCA }}=1.2 \mathrm{~V}$ to 5.5 V | $V_{\text {CCA }}-0.4$ |  |  |  |
| Input Low Voltage ${ }^{3}$ | VILA |  |  |  | 0.4 | V |
| Output High Voltage | Voha | $\mathrm{V}_{\mathrm{Y}}=\mathrm{V}_{\text {ccr }}$, $\mathrm{l}_{\text {oh }}=20 \mu \mathrm{~A}$, Figure 29 | VCCA -0.4 |  |  | V |
| Output Low Voltage | Vola | $\mathrm{V}_{\mathrm{Y}}=0 \mathrm{~V}$, lol $=20 \mu \mathrm{~A}$, Figure 29 |  |  | 0.4 | V |
| Capacitance ${ }^{3}$ | $\mathrm{C}_{\text {A }}$ | $\mathrm{f}=1 \mathrm{MHz}, \mathrm{EN}=0$, Figure 34 |  | 9 |  | pF |
| Leakage Current | LLa, hilz | $\mathrm{V}_{\mathrm{A}}=0 \mathrm{~V} / \mathrm{V}_{\text {cca }}, \mathrm{EN}=0$, Figure 31 |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Y Side |  |  |  |  |  |  |
| Input Low Voltage ${ }^{3}$ | $\mathrm{V}_{\mathrm{HY}}$ |  | $V_{\text {cCY }}-0.4$ |  |  | V |
| Input High Voltage ${ }^{3}$ | VILY |  |  |  | 0.4 | V |
| Output High Voltage | Vohy | $\mathrm{V}_{\mathrm{A}}=\mathrm{V}_{\text {CCA }}$, $\mathrm{IoH}=20 \mu \mathrm{~A}$, Figure 30 | Vccy -0.4 |  |  | V |
| Output Low Voltage | Voly | $\mathrm{V}_{\mathrm{A}}=0 \mathrm{~V}$, $\mathrm{loL}=20 \mu \mathrm{~A}$, Figure 30 |  |  | 0.4 | V |
| Capacitance ${ }^{3}$ | $\mathrm{Cr}_{Y}$ | $\mathrm{f}=1 \mathrm{MHz}, \mathrm{EN}=0$, Figure 35 |  | 6 |  | pF |
| Leakage Current | $\mathrm{lty}, \mathrm{hi}-\mathrm{z}$ | $\mathrm{V}_{\mathrm{Y}}=0 \mathrm{~V} / \mathrm{V}_{\text {ccr }}, \mathrm{EN}=0$, Figure 32 |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Enable (EN) |  |  |  |  |  |  |
| Input High Voltage ${ }^{3}$ | $V_{\text {Hen }}$ | $V_{\text {CCA }}=1.15 \mathrm{~V}$ | $V_{\text {CCA }}-0.3$ |  |  | V |
|  | Vihen | $\mathrm{V}_{\text {cca }}=1.2 \mathrm{~V}$ to 5.5 V | VCCA -0.4 |  |  | V |
| Input Low Voltage ${ }^{3}$ | $V_{\text {ILen }}$ |  |  |  | 0.4 | V |
| Leakage Current | Iten | $\mathrm{V}_{\mathrm{EN}}=0 \mathrm{~V} / \mathrm{V}_{\text {CCA }}, \mathrm{V}_{\mathrm{A}}=0 \mathrm{~V}$, Figure 33 |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Capacitance ${ }^{3}$ | $\mathrm{C}_{\text {en }}$ |  |  | 3 |  | pF |
| Enable Time ${ }^{3}$ | ten | $\begin{aligned} & R_{S}=R_{T}=50 \Omega, V_{A}=0 \mathrm{~V} / V_{C C A}(A \rightarrow Y), \\ & V_{Y}=0 \mathrm{~V} / V_{C C Y}(Y \rightarrow A), \text { Figure } 36 \end{aligned}$ |  | 1 | 1.8 | $\mu \mathrm{s}$ |
| SWITCHING CHARACTERISTICS ${ }^{3}$ |  |  |  |  |  |  |
| $3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} \leq \mathrm{V}_{C C A} \leq \mathrm{V}_{C C Y}, \mathrm{~V}_{C C Y}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$ |  |  |  |  |  |  |
| $\mathrm{A} \rightarrow \mathrm{Y}$ Level Translation |  | $\mathrm{R}_{S}=\mathrm{R}_{T}=50 \Omega, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$, Figure 37 |  |  |  |  |
| Propagation Delay | $t_{p, A \rightarrow Y}$ |  |  | 6 | 10 | ns |
| Rise Time | $t_{\text {R, } A \rightarrow Y}$ |  |  | 2 | 3.5 | ns |
| Fall Time |  |  |  | 2 | 3.5 | ns |
| Maximum Data Rate | $\mathrm{D}_{\text {MAX }, ~ A \rightarrow Y}$ |  | 50 |  |  | Mbps |
| Channel-to-Channel Skew | $t_{\text {SKEW, }} A^{\prime} \mathrm{Y}$ |  |  | 2 | 4 | ns |
| Part-to-Part Skew | tpPSKEW, A $\rightarrow$ Y |  |  |  | 3 | ns |
| $\mathrm{Y} \rightarrow \mathrm{A}$ Level Translation |  | $\mathrm{R}_{S}=\mathrm{R}_{\mathrm{T}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, Figure 38 |  |  |  |  |
| Propagation Delay | tp, $Y \rightarrow A$ |  |  | 4 | 7 | ns |
| Rise Time | $t_{R, Y \rightarrow A}$ |  |  | 1 | 3 | ns |
| Fall Time | $t_{\text {F, } Y \rightarrow A}$ |  |  | 3 | 7 | ns |
| Maximum Data Rate | $\mathrm{D}_{\text {MAX }, ~}^{\text {Y }}$ A |  | 50 |  |  | Mbps |
| Channel-to-Channel Skew | tskew, $Y \rightarrow A$ |  |  | 2 | 3.5 | ns |
| Part-to-Part Skew | tppskew, $\uparrow \rightarrow A$ |  |  |  | 2 | ns |
| $1.8 \mathrm{~V} \pm 0.15 \mathrm{~V} \leq \mathrm{V}_{C C A} \leq \mathrm{V}_{C C Y}, \mathrm{~V}_{C C Y}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ |  |  |  |  |  |  |
| $\mathrm{A} \rightarrow \mathrm{Y}$ Translation |  | $\mathrm{R}_{S}=\mathrm{R}_{\mathrm{T}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$, Figure 37 |  |  |  |  |
| Propagation Delay | $t \mathrm{P}, A \rightarrow Y$ |  |  | 8 | 11 | ns |
| Rise Time | $t_{R, A \rightarrow Y}$ |  |  | 2 | 5 | ns |
| Fall Time | $t_{\text {f, }} A_{\rightarrow} \boldsymbol{r}$ |  |  | 2 | 5 | ns |
| Maximum Data Rate | $\mathrm{D}_{\text {MAX }, ~}^{\text {¢ }}$, ${ }^{\text {r }}$ |  | 50 |  |  | Mbps |

## ADG3304

| Parameter | Symbol | Conditions | Min | Typ ${ }^{2}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Channel-to-Channel Skew | tSkEw, A $\rightarrow$ Y |  |  | 2 | 4 | ns |
| Part-to-Part Skew | tPPSKEW, $A \rightarrow Y$ |  |  |  | 4 | ns |
| $\mathrm{Y} \rightarrow \mathrm{A}$ Translation |  | $\mathrm{R}_{S}=\mathrm{R}_{\mathrm{T}}=50 \Omega, C_{L}=15 \mathrm{pF}$, Figure 38 |  |  |  |  |
| Propagation Delay | $t_{P, Y \rightarrow A}$ |  |  | 5 | 8 | ns |
| Rise Time | $t_{R, Y \rightarrow A}$ |  |  | 2 | 3.5 | ns |
| Fall Time | $\mathrm{t}_{\mathrm{F}, \mathrm{Y} \rightarrow \mathrm{A}}$ |  |  | 2 | 3.5 | ns |
| Maximum Data Rate | $D_{\text {MAX }, Y \rightarrow A}$ |  | 50 |  |  | Mbps |
| Channel-to-Channel Skew | tskew, $Y \rightarrow$ A |  |  | 2 | 3 | ns |
| Part-to-Part Skew | tPPSKEW, Y $\rightarrow$ A |  |  |  | 3 | ns |
| $\begin{aligned} & \text { 1.15 } \mathrm{V} \text { to } 1.3 \mathrm{~V} \leq \mathrm{V}_{\mathrm{CCA}} \leq \mathrm{V}_{\mathrm{CCY}}, \mathrm{~V}_{\mathrm{CCY}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} \\ & \mathrm{~A} \rightarrow \mathrm{Y} \text { Translation } \end{aligned}$ |  | $\mathrm{R}_{S}=\mathrm{R}_{T}=50 \Omega, C_{L}=50 \mathrm{pF}$, Figure 37 |  |  |  |  |
| Propagation Delay | $t_{P, A \rightarrow Y}$ |  |  | 9 | 18 | ns |
| Rise Time | $\mathrm{t}_{\mathrm{R}, \mathrm{A} \rightarrow \mathrm{Y}}$ |  |  | 3 | 5 | ns |
| Fall Time | $\mathrm{t}_{\mathrm{F}, \mathrm{A} \rightarrow \mathrm{Y}}$ |  |  | 2 | 5 | ns |
| Maximum Data Rate | $\mathrm{D}_{\text {MAX, }} \mathrm{A}_{\mathrm{H}} \mathrm{Y}$ |  | 40 |  |  | Mbps |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {SKEW, }} \mathrm{A} \rightarrow \mathrm{Y}$ |  |  | 2 | 5 | ns |
| Part-to-Part Skew | tPPSKEW, A $\rightarrow$ Y |  |  |  | 10 | ns |
| $\mathrm{Y} \rightarrow \mathrm{A}$ Translation |  | $\mathrm{R}_{S}=\mathrm{R}_{\mathrm{T}}=50 \Omega, \mathrm{C}_{L}=15 \mathrm{pF}$, Figure 38 |  |  |  |  |
| Propagation Delay | $t_{P, Y \rightarrow A}$ |  |  | 5 | 9 | ns |
| Rise Time | $t_{R, Y \rightarrow A}$ |  |  | 2 | 4 | ns |
| Fall Time | $\mathrm{t}_{\mathrm{F}, \mathrm{Y} \rightarrow \mathrm{A}}$ |  |  | 2 | 4 | ns |
| Maximum Data Rate | $D_{\text {MAX }, Y \rightarrow A}$ |  | 40 |  |  | Mbps |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {SKEW, }} \mathrm{Y} \rightarrow \mathrm{A}$ |  |  | 2 | 4 | ns |
| Part-to-Part Skew | tPPSKEW, Y $\rightarrow$ A |  |  |  | 4 | ns |
| $\begin{aligned} & \text { 1.15 } \mathrm{V} \text { to } 1.3 \mathrm{~V} \leq \mathrm{V}_{\mathrm{CCA}} \leq \mathrm{V}_{\mathrm{CCY}}, \mathrm{~V}_{\mathrm{CCY}}=1.8 \mathrm{~V} \pm 0.3 \mathrm{~V} \\ & \mathrm{~A} \rightarrow \mathrm{Y} \text { Translation } \end{aligned}$ |  | $\mathrm{R}_{S}=\mathrm{R}_{T}=50 \Omega, C_{L}=50 \mathrm{pF}$, Figure 37 |  |  |  |  |
| Propagation Delay | $t_{P, ~}^{\text {a }}$, $Y$ |  |  | 12 | 25 | ns |
| Rise Time | $t_{R, A \rightarrow Y}$ |  |  | 7 | 12 | ns |
| Fall Time | $t_{F, A \rightarrow Y}$ |  |  | 3 | 5 | ns |
| Maximum Data Rate | $D_{\text {MAX }, ~ A ~}^{\text {a }}$, |  | 25 |  |  | Mbps |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {SKEW, }} \mathrm{A} \rightarrow \mathrm{Y}$ |  |  | 2 | 5 | ns |
| Part-to-Part Skew | tPPSKEW, A $\rightarrow$ Y |  |  |  | 15 | ns |
| $Y \rightarrow$ Translation |  | $\mathrm{R}_{\mathrm{s}}=\mathrm{R}_{\mathrm{T}}=50 \Omega, \mathrm{C}_{L}=15 \mathrm{pF}$, Figure 38 |  |  |  |  |
| Propagation Delay | $t_{P, Y \rightarrow A}$ |  |  | 14 | 35 | ns |
| Rise Time | $\mathrm{t}_{\mathrm{R}, \mathrm{Y} \rightarrow \mathrm{A}}$ |  |  | 5 | 16 | ns |
| Fall Time | $\mathrm{t}_{\mathrm{F}, \mathrm{Y} \rightarrow \mathrm{A}}$ |  |  | 2.5 | 6.5 | ns |
| Maximum Data Rate | $D_{\text {MAX }, Y \rightarrow A}$ |  | 25 |  |  | Mbps |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {SKEW, }}{ }_{\text {l }} \rightarrow \mathrm{A}$ |  |  | 3 | 6.5 | ns |
| Part-to-Part Skew | $\mathrm{t}_{\text {PPSKEW, }} \mathrm{Y} \rightarrow \mathrm{A}$ |  |  |  | 23.5 | ns |
| $\begin{aligned} & 2.5 \mathrm{~V} \pm 0.2 \mathrm{~V} \leq \mathrm{V}_{\mathrm{CCA}} \leq \mathrm{V}_{\mathrm{CC}}, \mathrm{~V}_{\mathrm{CCY}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} \\ & \mathrm{~A} \rightarrow \mathrm{Y} \text { Translation } \end{aligned}$ |  | $\mathrm{R}_{s}=R_{T}=50 \Omega, C_{L}=50 \mathrm{pF}$, Figure 37 |  |  |  |  |
| Propagation Delay | $t_{P, A \rightarrow Y}$ |  |  | 7 | 10 | ns |
| Rise Time | $t_{R, A \rightarrow Y}$ |  |  | 2.5 | 4 | ns |
| Fall Time | $t_{F, A \rightarrow Y}$ |  |  | 2 | 5 | ns |
| Maximum Data Rate | $\mathrm{Dmax}_{\text {, }} \rightarrow$ $\rightarrow$ Y |  | 60 |  |  | Mbps |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {SKEW, }} \rightarrow$ ¢ ${ }^{\text {r }}$ |  |  | 1.5 | 2 | ns |
| Part-to-Part Skew | tPPSKEW, $^{\text {a }}$, ${ }^{\text {r }}$ |  |  |  | 4 | ns |


| Parameter | Symbol | Conditions | Min | Typ ${ }^{2}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{Y} \rightarrow \mathrm{A}$ Translation |  | $\mathrm{R}_{\mathrm{S}}=\mathrm{R}_{\mathrm{T}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, Figure 38 |  |  |  |  |
| Propagation Delay | $t_{p, Y \rightarrow A}$ |  |  | 5 | 8 | ns |
| Rise Time | $t_{R, Y \rightarrow A}$ |  |  | 1 | 4 | ns |
| Fall Time | $t_{F, Y \rightarrow A}$ |  |  | 3 | 5 | ns |
| Maximum Data Rate | $\mathrm{D}_{\text {max },} \mathrm{r} \rightarrow \mathrm{A}$ |  | 60 |  |  | Mbps |
| Channel-to-Channel Skew | $\mathrm{t}_{\text {SKEW, }, ~}^{\text {Y }}$ A |  |  | 2 | 3 | ns |
| Part-to-Part Skew | tpPSKEw, $Y \rightarrow$ A |  |  |  | 3 | ns |
| POWER REQUIREMENTS |  |  |  |  |  |  |
| Power Supply Voltages | $\mathrm{V}_{\text {CCA }}$ | $\mathrm{V}_{\text {CCA }} \leq \mathrm{V}_{\text {CCY }}$ | 1.15 |  | 5.5 | V |
|  | $\mathrm{V}_{\text {cCr }}$ |  | 1.65 |  | 5.5 | V |
| Quiescent Power Supply Current | ICCA | $\begin{aligned} & V_{A}=0 \mathrm{~V} / \mathrm{V}_{C C A}, \mathrm{~V}_{\mathrm{Y}}=0 \mathrm{~V} / \mathrm{V}_{C C Y}, \\ & V_{C C A}=V_{C C Y}=5.5 \mathrm{~V}, \mathrm{EN}=1 \end{aligned}$ | 0.17 |  | 5 | $\mu \mathrm{A}$ |
|  | lcCr | $\begin{aligned} & \mathrm{V}_{\mathrm{A}}=0 \mathrm{~V} / \mathrm{V}_{\mathrm{CCA}}, \mathrm{~V}_{\mathrm{Y}}=0 \mathrm{~V} / \mathrm{V}_{\mathrm{CCY}}, \\ & \mathrm{~V}_{\mathrm{CCA}}=\mathrm{V}_{\mathrm{CCY}}=5.5 \mathrm{~V}, \mathrm{EN}=1 \end{aligned}$ |  | 0.27 | 5 | $\mu \mathrm{A}$ |
| Three-State Mode Power Supply Current | $\mathrm{I}_{\mathrm{Hiz}, \mathrm{A}}$ | $\mathrm{V}_{\text {CCA }}=\mathrm{V}_{\text {CCY }}=5.5 \mathrm{~V}, \mathrm{EN}=0$ |  | 0.1 | 5 | $\mu \mathrm{A}$ |
|  | $\mathrm{I}_{\mathrm{Hi}-\mathrm{Z}, \mathrm{Y}}$ | $\mathrm{V}_{\text {CCA }}=\mathrm{V}_{\text {CCY }}=5.5 \mathrm{~V}, \mathrm{EN}=0$ |  | 0.1 | 5 | $\mu \mathrm{A}$ |

${ }^{1}$ Temperature range is as follows: $B$ version: $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.
${ }^{2} \mathrm{All}$ typical values are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted.
${ }^{3}$ Guaranteed by design; not subject to production test.

## ABSOLUTE MAXIMUM RATINGS

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted.
Table 2.

| Parameter | Rating |
| :---: | :---: |
| $V_{\text {cca }}$ to GND | -0.3 V to +7 V |
| Vccr to GND | V cca to +7 V |
| Digital Inputs (A) | -0.3 V to ( $\mathrm{V}_{\text {cca }}+0.3 \mathrm{~V}$ ) |
| Digital Inputs (Y) | -0.3 V to ( $\left.\mathrm{V}_{\mathrm{ccr}}+0.3 \mathrm{~V}\right)$ |
| EN to GND | -0.3 V to +7 V |
| Operating Temperature Range Industrial (B Version) | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| Storage Temperature Range | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Junction Temperature | $150^{\circ} \mathrm{C}$ |
| $\theta_{\mathrm{JA}}$ Thermal Impedance (4-Layer Board) |  |
| 14-Lead TSSOP | $89.21^{\circ} \mathrm{C} / \mathrm{W}$ |
| 12-Bump WLCSP | $120^{\circ} \mathrm{C} / \mathrm{W}$ |
| 20-Lead LFCSP | $30.4{ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Lead Temperature, Soldering (10 sec) | $300^{\circ} \mathrm{C}$ |
| IR Reflow, Peak Temperature (<20 sec) | $260^{\circ} \mathrm{C}$ |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Only one absolute maximum rating may be applied at any one time.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.


## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



Figure 2. 14-Lead TSSOP


Figure 3. 12-Bump WLCSP


NC = NO CONNECT
NOTES

1. THE EXPOSED PADDLE CAN BE TIED TO GND OR LEFT FLOATING. DO NOT TIE IT TO $\mathrm{V}_{\mathrm{CCA}}$ or $\mathrm{V}_{\mathrm{CCY}}$.

Figure 4. 20-Lead LFCSP

Table 3. 14-Lead TSSOP and 20-lead LFCSP Pin Function Descriptions

| Pin No. |  | Mnemonic | Description |
| :---: | :---: | :---: | :---: |
| TSSOP | LFCSP |  |  |
| 1 | 19 | V cca | Power Supply Voltage Input for the A 1 to $\mathrm{A} 4 \mathrm{I} / \mathrm{O}$ Pins ( $1.15 \mathrm{~V} \leq \mathrm{V}_{\text {cca }} \leq \mathrm{V}_{\text {ccr }}$ ). |
| 2 | 20 | A1 | Input/Output A1. Referenced to V cca . |
| 3 | 2 | A2 | Input/Output A2. Referenced to V cca . |
| 4 | 3 | A3 | Input/Output A3. Referenced to V cca . |
| 5 | 4 | A4 | Input/Output A4. Referenced to V cca . |
| 6,9 | 1,5,6, 7, 10, 11, 15, 16 | NC | No Connect. |
| 7 | 8 | GND | Ground. |
| 8 | 9 | EN | Active High Enable Input. |
| 10 | 12 | Y4 | Input/Output Y4. Referenced to $\mathrm{V}_{\text {ccr }}$. |
| 11 | 13 | Y3 | Input/Output Y3. Referenced to V ccr. |
| 12 | 14 | Y2 | Input/Output Y2. Referenced to $\mathrm{V}_{\text {ccr }}$. |
| 13 | 17 | Y1 | Input/Output Y1. Referenced to V ccr . |
| 14 | 18 | $\mathrm{V}_{\mathrm{CCr}}$ | Power Supply Voltage Input for the Y1 to Y4 I/O Pins ( $1.65 \mathrm{~V} \leq \mathrm{V}_{\mathrm{cc}} \leq 5.5 \mathrm{~V}$ ). |

Table 4. 12-Bump WLCSP Bump Function Descriptions

| Bump No. | Mnemonic | Description |
| :---: | :---: | :---: |
| a1 | Y1 | Input/Output Y1. Referenced to $\mathrm{V}_{\text {ccr }}$. |
| a2 | Y2 | Input/Output Y2. Referenced to $\mathrm{V}_{\text {ccr }}$. |
| a3 | Y3 | Input/Output Y3. Referenced to $\mathrm{V}_{\text {ccr }}$. |
| a4 | Y4 | Input/Output Y4. Referenced to V ccr . |
| b1 | $\mathrm{V}_{\text {CCY }}$ | Power Supply Voltage Input for the Y1 to Y4 I/O Pins ( $1.65 \mathrm{~V} \leq \mathrm{V}_{\text {cc }} \leq 5.5 \mathrm{~V}$ ). |
| b2 | VCCA | Power Supply Voltage Input for the A 1 to $\mathrm{A} 4 \mathrm{I} / \mathrm{O}$ Pins ( $1.15 \mathrm{~V} \leq \mathrm{V}_{\text {cCA }} \leq \mathrm{V}_{\text {ccr }}$ ). |
| b3 | EN | Active High Enable Input. |
| b4 | GND | Ground. |
| c1 | A1 | Input/Output A1. Referenced to V cca . |
| c2 | A2 | Input/Output A2. Referenced to V cca . |
| c3 | A3 | Input/Output A3. Referenced to V cca . |
| c4 | A4 | Input/Output A4. Referenced to V cca . |

## ADG3304

TYPICAL PERFORMANCE CHARACTERISTICS


Figure 5. IccA vs. Data Rate $(A \rightarrow Y$ Level Translation)


Figure 6. Iccr vs. Data Rate $(A \rightarrow Y$ Level Translation)


Figure 7. IICCA Vs. Data Rate ( $Y \rightarrow$ A Level Translation)


Figure 8. Iccy vs. Data Rate $(Y \rightarrow A$ Level Translation)


Figure 9. Iccr vs. Capacitive Load at Pin $Y$ for $A \rightarrow Y(1.2 V \rightarrow 1.8 V)$ Level Translation


Figure 10. Icca vs. Capacitive Load at Pin $A$ for $Y \rightarrow A(1.8 \mathrm{~V} \rightarrow 1.2 \mathrm{~V})$ Level Translation


Figure 11. Iccy vs. Capacitive Load at Pin Y for $A \rightarrow Y(1.8 \mathrm{~V} \rightarrow 3.3 \mathrm{~V})$ Level Translation


Figure 12. ICCA vs. Capacitive Load at Pin $A$ for $Y \rightarrow A(3.3 V \rightarrow 1.8 \mathrm{~V})$ Level Translation


Figure 13. Iccy vs. Capacitive Load at Pin $Y$ for $A \rightarrow Y(3.3 V \rightarrow 5 V)$ Level Translation


Figure 14. Icca vs. Capacitive Load at Pin A for $Y \rightarrow A(5 \mathrm{~V} \rightarrow 3.3 \mathrm{~V})$ Level Translation


Figure 15. Rise Time vs. Capacitive Load at Pin $Y(A \rightarrow Y$ Level Translation)


Figure 16. Fall Time vs. Capacitive Load at Pin $Y(A \rightarrow Y$ Level Translation)

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Figure 17. Rise Time vs. Capacitive Load at Pin A ( $Y \rightarrow$ A Level Translation)


Figure 18. Fall Time vs. Capacitive Load at Pin $A(Y \rightarrow A$ Level Translation)


Figure 19. Propagation Delay (tPLH) vs.
Capacitive Load at Pin $Y(A \rightarrow Y$ Level Translation)


Figure 20. Propagation Delay ( $t_{\text {PHL }}$ ) vs. Capacitive Load at Pin $Y(A \rightarrow Y$ Level Translation)


Figure 21. Propagation Delay ( $t_{\text {PLH }}$ ) vs. Capacitive Load at Pin A $(Y \rightarrow A$ Level Translation)


Figure 22. Propagation Delay ( $t_{\text {PHL }}$ ) vs. Capacitive Load at Pin A $(Y \rightarrow$ Level Translation)


Figure 23. Eye Diagram at Y Output (1.2 V to 1.8 V Level Translation, 25 Mbps )


Figure 24. Eye Diagram at A Output (1.8 V to 1.2 V Level Translation, 25 Mbps )


Figure 25. Eye Diagram at $Y$ Output (1.8 V to 3.3 V Level Translation, 50 Mbps )


Figure 26. Eye Diagram at A Output (3.3 V to 1.8 V Level Translation, 50 Mbps)


Figure 27. Eye Diagram at Y Output (3.3 V to 5 V Level Translation, 50 Mbps )


Figure 28. Eye Diagram at A Output (5 V to 3.3 V Level Translation, 50 Mbps )

## ADG3304

## TEST CIRCUITS



Figure 29. $V_{O H} / V_{\text {OL }}$ Voltages at Pin $A$


Figure 30. $V_{\mathrm{OH}} / V_{\text {OL }}$ Voltages at $\operatorname{Pin} Y$


Figure 31. Three-State Leakage Current at Pin A


Figure 32. Three-State Leakage Current at Pin $Y$


Figure 33. EN Pin Leakage Current


Figure 34. Capacitance at Pin A


Figure 35. Capacitance at Pin $Y$

## $A \rightarrow Y$ DIRECTION



NOTES

1. $\mathrm{t}_{\text {EN }}$ IS WHICHEVER IS LARGER BETWEEN $\mathrm{t}_{\text {EN1 } 1}$ AND $\mathrm{t}_{\text {EN } 2}$ IN BOTH A $\rightarrow$ Y AND $Y \rightarrow$ A DIRECTIONS.

Figure 36. Enable Time

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Figure 37. Switching Characteristics $(A \rightarrow Y$ Level Translation)


Figure 38. Switching Characteristics $(Y \rightarrow A$ Level Translation)

## TERMINOLOGY

Table 5.

| Symbol | Description |
| :---: | :---: |
| $\mathrm{V}_{\text {HA }}$ | Logic input high voltage at Pins A1 to A4. |
| VILA | Logic input low voltage at Pins A1 to A4. |
| Voha | Logic output high voltage at Pins A1 to A4. |
| Vola | Logic output low voltage at Pins A1 to A4. |
| $\mathrm{C}_{\text {A }}$ | Capacitance measured at Pins A1 to A4 ( $\mathrm{EN}=0)$. |
| Lla, hilz | Leakage current at Pins A1 to A4 when EN = (high impedance state at Pins A1 to A4). |
| $\mathrm{V}_{\mathrm{HY}}$ | Logic input high voltage at Pins Y1 to Y4. |
| VILY | Logic input low voltage at Pins Y1 to Y4. |
| Vohy | Logic output high voltage at Pins Y1 to Y4. |
| Voly | Logic output low voltage at Pins Y1 to Y4. |
| $\mathrm{Cr}_{Y}$ | Capacitance measured at Pins Y 1 to $\mathrm{Y} 4(\mathrm{EN}=0)$. |
| $\mathrm{ILy}_{\text {ly hizz }}$ | Leakage current at Pins Y 1 to Y 4 when $\mathrm{EN}=0$ (high impedance state at Pins Y 1 to Y4). |
| Vihen | Logic input high voltage at the EN pin. |
| $V_{\text {ILEN }}$ | Logic input low voltage at the EN pin. |
| $\mathrm{C}_{\text {en }}$ | Capacitance measured at EN pin. |
| Ilen | Enable (EN) pin leakage current. |
| ten | Three-state enable time for Pins A1 to A4 /Y1 to Y4. |
| $t_{P, A \rightarrow Y}$ | Propagation delay when translating logic levels in the $A \rightarrow Y$ direction. |
| $t_{R, A \rightarrow Y}$ | Rise time when translating logic levels in the $A \rightarrow Y$ direction. |
| $t_{\text {F, } A \rightarrow Y}$ | Fall time when translating logic levels in the $A \rightarrow Y$ direction. |
| $\mathrm{D}_{\text {Max }, ~}^{\text {A }}$, | Guaranteed data rate when translating logic levels in the $A \rightarrow Y$ direction under the driving and loading conditions specified in Table 1. |
| $\mathrm{t}_{\text {SKEW, }} \mathrm{A} \rightarrow \mathrm{Y}$ | Difference between propagation delays on any two channels when translating logic levels in the $A \rightarrow Y$ direction. |
| tpPSKEw, A $\rightarrow$ Y | Difference in propagation delay between any one channel and the same channel on a different part (under same driving/loading conditions) when translating in the $A \rightarrow Y$ direction. |
| $t_{P, Y \rightarrow A}$ | Propagation delay when translating logic levels in the $Y \rightarrow A$ direction. |
| $t_{R, Y \rightarrow A}$ | Rise time when translating logic levels in the $Y \rightarrow A$ direction. |
| $t_{F, Y \rightarrow A}$ | Fall time when translating logic levels in the $Y \rightarrow A$ direction. |
| $\mathrm{D}_{\text {MaX, }, ~}^{\text {¢ }}$ A | Guaranteed data rate when translating logic levels in the $Y \rightarrow A$ direction under the driving and loading conditions specified in Table 1. |
| $t_{\text {SKEW, } Y \rightarrow A}$ | Difference between propagation delays on any two channels when translating logic levels in the $\mathrm{Y} \rightarrow \mathrm{A}$ direction. |
| tpPSKEw, $\varphi \rightarrow$ A | Difference in propagation delay between any one channel and the same channel on a different part (under the same driving/loading conditions) when translating in the $Y \rightarrow A$ direction. |
| VCCA | Vcca supply voltage. |
| $\mathrm{V}_{\text {çr }}$ | $\mathrm{V}_{\text {ccr }}$ supply voltage. |
| $I_{\text {cca }}$ | $V_{\text {cca }}$ supply current. |
| Iccy | $V_{\text {ccr }}$ supply current. |
| $\mathrm{I}_{\mathrm{Hiz}, \mathrm{Z}}$ | $V_{\text {cca }}$ supply current during three-state mode ( $\mathrm{EN}=0$ ). |
| $\mathrm{ItizZ}, \mathrm{Y}$ | $\mathrm{V}_{\text {ccr }}$ supply current during three-state mode ( $\mathrm{EN}=0$ ). |

## ADG3304

## THEORY OF OPERATION

The ADG3304 level translator allows the level shifting necessary for data transfer in a system where multiple supply voltages are used. The device requires two supplies, $V_{C C A}$ and $\mathrm{V}_{\mathrm{CCY}}\left(\mathrm{V}_{\mathrm{CCA}} \leq \mathrm{V}_{\mathrm{CCY}}\right)$. These supplies set the logic levels on each side of the device. When driving the A pins, the device translates the $\mathrm{V}_{\text {CCA }}$-compatible logic levels to $\mathrm{V}_{\mathrm{CCY}}$-compatible logic levels available at the Y pins. Similarly, since the device is capable of bidirectional translation, when driving the Y pins, the $\mathrm{V}_{\mathrm{CCY}}{ }^{-}$ compatible logic levels are translated to $\mathrm{V}_{\mathrm{CCA}}$-compatible logic levels available at the A pins. When $\mathrm{EN}=0$, the A1 to A4 and Y1 to Y4 pins are three-stated. When EN is driven high, the ADG3304 goes into normal operation mode and performs level translation.

## LEVEL TRANSLATOR ARCHITECTURE

The ADG3304 consists of four bidirectional channels. Each channel can translate logic levels in either the $\mathrm{A} \rightarrow \mathrm{Y}$ or the $\mathrm{Y} \rightarrow \mathrm{A}$ direction. It uses a one-shot accelerator architecture, which ensures excellent switching characteristics. Figure 39 shows a simplified block diagram of a bidirectional channel.


Figure 39. Simplified Block Diagram of an ADG3304 Channel
The logic level translation in the $A \rightarrow Y$ direction is performed using a level translator (U1) and an inverter (U2), while the translation in the $\mathrm{Y} \rightarrow \mathrm{A}$ direction is performed using the inverters U3 and U4. The one-shot generator detects a rising or falling edge present on either the A side or the Y side of the channel. It sends a short pulse that turns on the PMOS transistors (T1 to T 2 ) for a rising edge, or the NMOS transistors (T3 to T4) for a falling edge. This charges/discharges the capacitive load faster, which results in fast rise and fall times.

The inputs of the unused channels (A or Y) should be tied to their corresponding $\mathrm{V}_{\mathrm{CC}}$ rail ( $\mathrm{V}_{\mathrm{CCA}}$ or $\mathrm{V}_{\mathrm{CCY}}$ ) or to GND.

## INPUT DRIVING REQUIREMENTS

To ensure correct operation of the ADG3304, the circuit that drives the input of the ADG3304 channels should have an output impedance of less than or equal to $150 \Omega$ and a minimum peak current driving capability of 36 mA .

## OUTPUT LOAD REQUIREMENTS

The ADG3304 level translator is designed to drive CMOScompatible loads. If current-driving capability is required, it is recommended to use buffers between the ADG3304 outputs and the load.

## ENABLE OPERATION

The ADG3304 provides three-state operation at the A and Y I/O pins by using the enable (EN) pin, as shown in Table 6.
Table 6. Truth Table

| EN | Y I/O Pins | A I/O Pins |
| :--- | :--- | :--- |
| 0 | $\mathrm{Hi}^{1}$ | $\mathrm{Hi}^{1} \mathrm{Z}^{1}$ |
| 1 | Normal operation $^{2}$ | Normal operation $^{2}$ |

${ }^{1}$ High impedance state.
${ }^{2}$ In normal operation, the ADG3304 performs level translation.
While EN $=0$, the ADG3304 enters into three-state mode. In this mode, the current consumption from both the $V_{C C A}$ and $V_{C C Y}$ supplies is reduced, allowing the user to save power, which is critical, especially on battery-operated systems. The EN input pin can be driven with either $\mathrm{V}_{\mathrm{CCA}}-$ or $\mathrm{V}_{\mathrm{CCY}}-\mathrm{compatible}$ logic levels.

## POWER SUPPLIES

For proper operation of the ADG3304, the voltage applied to the $\mathrm{V}_{\mathrm{CCA}}$ must be always less than or equal to the voltage applied to Vccy. To meet this condition, the recommended power-up sequence is $V_{C C y}$ first and then $V_{c c a}$. The ADG3304 operates properly only after both supply voltages reach their nominal values. It is not recommended to use the part in a system where, during power-up, $\mathrm{V}_{\mathrm{CCA}}$ may be greater than $\mathrm{V}_{\mathrm{CCY}}$ due to a significant increase in the current taken from the $V_{\text {CCA }}$ supply. For optimum performance, the $V_{C C A}$ and $V_{C C Y}$ pins should be decoupled to GND as close as possible to the device.

## DATA RATE

The maximum data rate at which the device is guaranteed to operate is a function of the $V_{C C A}$ and $V_{C C Y}$ supply voltage combination and the load capacitance. It is given by the maximum frequency of a square wave that can be applied to the device, which meets the $\mathrm{V}_{\text {OH }}$ and $V_{\text {oL }}$ levels at the output and does not exceed the maximum junction temperature (see the Absolute Maximum Ratings section). Table 7 shows the guaranteed data rates at which the ADG3304 can operate in both directions ( $\mathrm{A} \rightarrow \mathrm{Y}$ or $\mathrm{Y} \rightarrow \mathrm{A}$ level translation) for various $\mathrm{V}_{\mathrm{CCA}}$ and $V_{C C Y}$ supply combinations.

Table 7. Guaranteed Data Rate (Mbps) ${ }^{1}$

| $\mathrm{V}_{\text {cca }}$ | Vccr |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
|  | $\begin{gathered} \hline 1.8 \mathrm{~V} \\ (1.65 \mathrm{~V} \text { to } 1.95 \mathrm{~V}) \end{gathered}$ | $\begin{gathered} 2.5 \mathrm{~V} \\ (2.3 \mathrm{~V} \text { to } 2.7 \mathrm{~V}) \end{gathered}$ | $\begin{gathered} 3.3 \mathrm{~V} \\ (3.0 \mathrm{~V} \text { to } 3.6 \mathrm{~V}) \end{gathered}$ | $\begin{gathered} \hline 5 \mathrm{~V} \\ (4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}) \end{gathered}$ |
| $1.2 \mathrm{~V}(1.15 \mathrm{~V}$ to 1.3 V$)$ | 25 | 30 | 40 | 40 |
| $1.8 \mathrm{~V}(1.65 \mathrm{~V}$ to 1.95 V$)$ | - | 45 | 50 | 50 |
| $2.5 \mathrm{~V}(2.3 \mathrm{~V}$ to 2.7 V$)$ | - | - | 60 | 50 |
| $3.3 \mathrm{~V}(3.0 \mathrm{~V}$ to 3.6 V$)$ | - | - | - | 50 |
| $5 \mathrm{~V}(4.5 \mathrm{~V}$ to 5.5 V$)$ | - | - | - | - |

[^0]
## ADG3304

## APPLICATIONS

The ADG3304 is designed for digital circuits that operate at different supply voltages; therefore, logic level translation is required. The lower voltage logic signals are connected to the A pins, and the higher voltage logic signals are connected to the Y pins. The ADG3304 can provide level translation in both directions from $\mathrm{A} \rightarrow \mathrm{Y}$ or $\mathrm{Y} \rightarrow \mathrm{A}$ on all four channels, eliminating the need for a level translator IC for each direction. The internal architecture allows the ADG3304 to perform bidirectional level translation without an additional signal to set the direction in which the translation is made. It also allows simultaneous data flow in both directions on the same part, for example, when two channels translate in $\mathrm{A} \rightarrow \mathrm{Y}$ direction while the other two translate in $\mathrm{Y} \rightarrow \mathrm{A}$ direction. This simplifies the design by eliminating the timing requirements for the direction signal and reduces the number of ICs used for level translation.

Figure 40 shows an application where two microprocessors operating at 1.8 V and 3.3 V , respectively, can transfer data simultaneously using two full-duplex serial links, TX1/RX1 and TX2/RX2.


Figure 40. 1.8 V to 3.3 V Level Translation Circuit on Two Full-Duplex Serial Links

When the application requires level translation between a microprocessor and multiple peripheral devices, the ADG3304 I/O pins can be three-stated by setting EN $=0$. This feature allows the ADG3304 to share the data buses with other devices without causing contention issues. Figure 41 shows an application where a 1.8 V microprocessor is connected to 3.3 V peripheral devices using the three-state feature.


Figure 41. 1.8 V to 3.3 V Level Translation Circuit Using the Three-State Feature

## LAYOUT GUIDELINES

As with any high speed digital IC, the printed circuit board layout is important for the overall performance of the circuit. Care should be taken to ensure proper power supply bypass and return paths for the high speed signals. Each $\mathrm{V}_{\mathrm{CC}}$ pin ( $\mathrm{V}_{\mathrm{CCA}}$ and $\mathrm{V}_{\mathrm{CCY}}$ ) should be bypassed using low effective series resistance (ESR) and effective series inductance (ESI) capacitors placed as close as possible to the $\mathrm{V}_{\text {cca }}$ and $\mathrm{V}_{\mathrm{ccy}}$ pins. The parasitic inductance of the high speed signal track might cause significant overshoot. This effect can be reduced by keeping the length of the tracks as short as possible. A solid copper plane for the return path (GND) is also recommended.

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB-1
Figure 42. 14-Lead Thin Shrink Small Outline Package [TSSOP]
(RU-14)
Dimensions shown in millimeters


Figure 43. 12-Bump Wafer Level Chip Scale Package [WLCSP] (CB-12)
Dimensions shown in millimeters


COMPLIANT TO JEDEC STANDARDS MO-220-VGGD-1
Figure 44. 20-Lead Lead Frame Chip Scale Package [LFCSP_VQ]
$4 \times 4$ mm Body, Very Thin Quad (CP-20-1)
Dimensions shown in millimeters

ORDERING GUIDE

| Model | Temperature Range | Package Description | Branding ${ }^{1}$ | Package <br> Option |
| :--- | :--- | :--- | :--- | :--- |
| ADG3304BRUZ ${ }^{2}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 14-Lead Thin Shrink Small Outline Package [TSSOP] |  | RU-14 |
| ADG3304BRUZ-REEL ${ }^{2}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 14-Lead Thin Shrink Small Outline Package [TSSOP] |  | RU-14 |
| ADG3304BRUZ-REEL7 $^{2}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 14-Lead Thin Shrink Small Outline Package [TSSOP] |  | RU-14 |
| ADG3304BCPZ-REEL ${ }^{2}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 20-Lead Lead Frame Chip Scale Package [LFCSP_VQ] |  | CP-20-1 |
| ADG3304BCPZ-REEL7 ${ }^{2}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 20-Lead Lead Frame Chip Scale Package [LFCSP_VQ] |  | CP-20-1 |
| ADG3304BCBZ-REEL ${ }^{2,3}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 12-Bump Wafer Level Chip Scale Package [WLCSP] | SDC | CB-12 |
| ADG3304BCBZ-REEL7 ${ }^{2,3}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 12-Bump Wafer Level Chip Scale Package [WLCSP] | SDC | CB-12 |

[^1]
## ADG3304

## NOTES


[^0]:    ${ }^{1}$ The load capacitance used is 50 pF when translating in the $\mathrm{A} \rightarrow \mathrm{Y}$ direction and 15 pF when translating in the $\mathrm{Y} \rightarrow \mathrm{A}$ direction.

[^1]:    ${ }^{1}$ Branding on these packages is limited to three characters due to space constraints.
    ${ }^{2} \mathrm{Z}=\mathrm{Pb}$-free part.
    ${ }^{3}$ Contact your sales representative for availability. Product under development.

